MOS-TECH Semiconductor Co.,LTD 臺灣茂鈿半導體股份有限公司

November 2010

MH&\$' \$

N-Channel Power[®] MOSFET 30 V, & A, 1+.5 m Ω

Features

- Max $r_{DS(on)}$ = 17.5 m Ω at V_{GS} = 10 V, I_D = 12 A
- Max $r_{DS(on)}$ = 24.5 m Ω at V_{GS} = 4.5 V, I_D = 10 A
- High performance technology for extremely low r_{DS(on)}
- Termination is Lead-free and RoHS Compliant

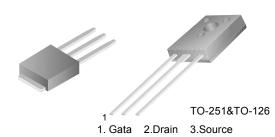


General Description

This N-Channel MOSFET is produced using MOS-TECH Semiconductor's advanced Power[®] process that has been especially tailored to minimize the on-state resistance.This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Applications

- DC/DC Buck Converters
- Notebook battery power management
- Load Switch in Notebook





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units		
V _{DS}	Drain to Source Voltage			30	V		
V _{GS}	Gate to Source Voltage		(Note 4)	±20	V		
	Drain Current -Continuous (Package limited)	$T_C = 25^{\circ}C$		20			
	-Continuous (Silicon limited)	T _C = 25°C		38			
I _D	-Continuous	$T_A = 25^{\circ}C$	(Note 1a)	12	Α		
	-Pulsed			50			
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	21	mJ		
P _D	Power Dissipation	T _C = 25°C		25	14/		
	Power Dissipation	T _A = 25°C	(Note 1a)	2.4	W		
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C		

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	5.0	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (Note 1	a) 53	C/VV

Package Marking and Ordering Information

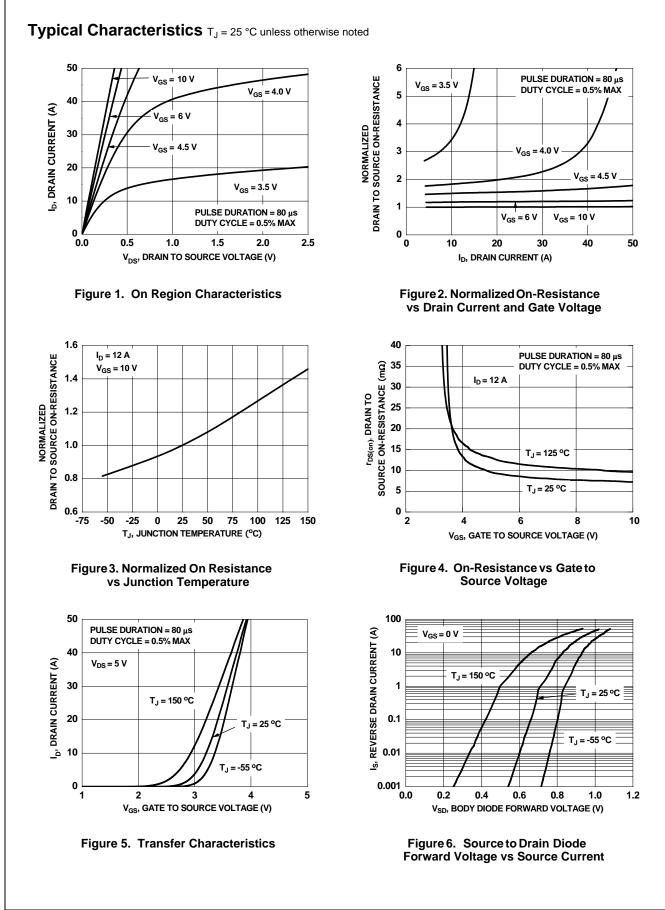
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT2030	MT2030	TO-251&126	-	-	50 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	30			V
∆BV _{DSS}	Breakdown Voltage Temperature		00			
ΔT_J	Coefficient	I_D = 250 μ A, referenced to 25 °C		14		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$			1	μA
I _{GSS}	Gate to Source Leakage Current, Forward	$V_{GS} = 20 V, V_{DS} = 0 V$			100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	1.2	1.8	2.0	V
$\Delta V_{GS(th)}$	Gate to Source Threshold Voltage					
ΔT_J	Temperature Coefficient	$I_D = 250 \ \mu A$, referenced to 25 °C		-6		mV/°C
		$V_{GS} = 10$ V, $I_{D} = 12$ A		17.5	19.5	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 V, I_{D} = 10 A$		24.5	26	mΩ
00(01)		V _{GS} = 10 V, I _D = 12 A, T _J = 125 °C		18.6	25.7	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 12 A		45		S
Dynamic	Characteristics					
•				1075	1430	ъĘ
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V,		380	505	pF
C _{oss}	Output Capacitance	f = 1 MHz				pF
C _{rss}	Reverse Transfer Capacitance Gate Resistance		0.2	40 1.0	55 2.0	pF
R _g	Gale Resistance		0.2	1.0	2.0	Ω
Switching	g Characteristics					
t _{d(on)}	Turn-On Delay Time			9	18	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 12 A,		2	10	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		19	33	ns
t _f	Fall Time			2	10	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V		16	22	nC
Q _g	Total Gate Charge	$V_{GS} = 0 V \text{ to } 5 V V_{DD} = 15 V,$		8	11	nC
Q _{gs}	Gate to Source Charge	I _D = 12 A		3.2		nC
Q _{gd}	Gate to Drain "Miller" Charge			1.8		nC
Drain-Sou	urce Diode Characteristics					
		V _{GS} = 0 V, I _S = 1.9 A (Note 2)		0.75	1.2	
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 12 A$ (Note 2)		0.84	1.2	V
t _{rr}	Reverse Recovery Time			25	40	ns
Q _{rr}	Reverse Recovery Charge	- I _F = 12 A, di/dt = 100 A/μs		9	18	nC
Notes:	ined with the device mounted on a 1 in ² pad 2 oz copper pad rd design. a. 53 °C/W when mount 1 in ² pad of 2 oz cop	ted on a	b. 125 °C/W	by design wh when mounte pad of 2 oz c	ed on a	etermined b

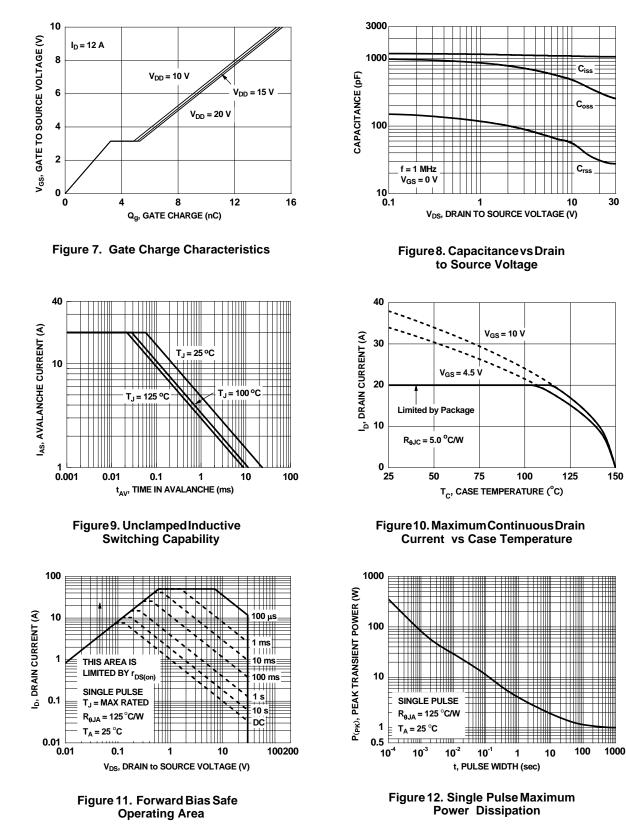
2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

3. E_{AS} of 21 mJ is based on starting T_J = 25 °C, L = 0.3 mH, I_{AS} = 12 A, V_{DD} = 27 V, V_{GS} = 10 V.

4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

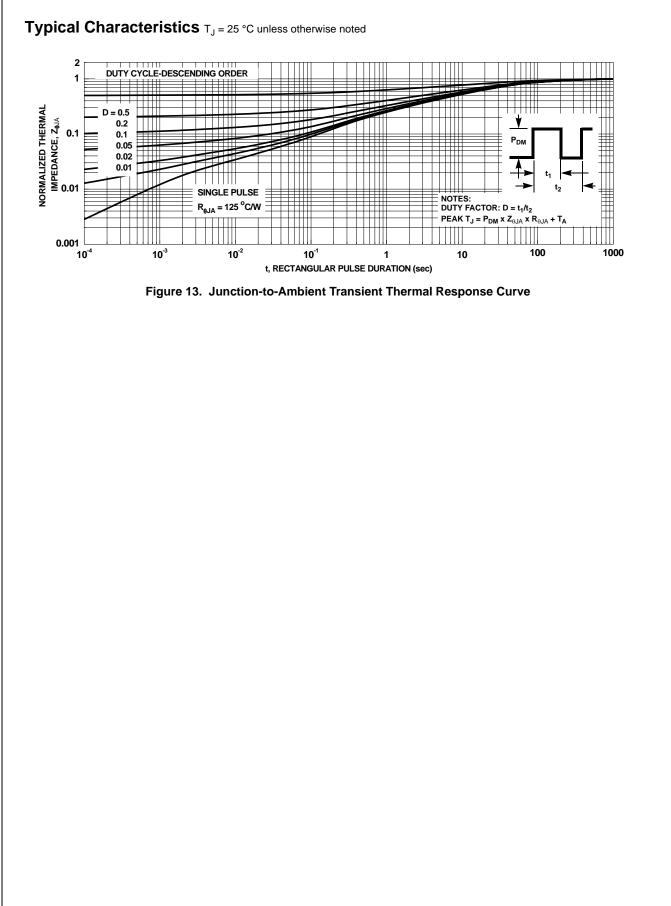




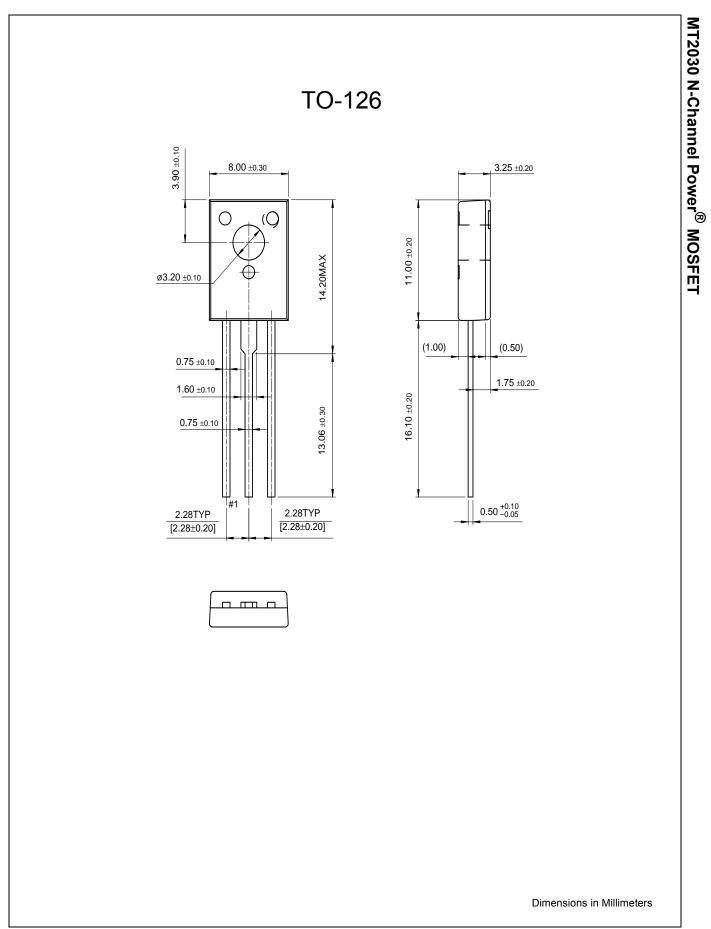


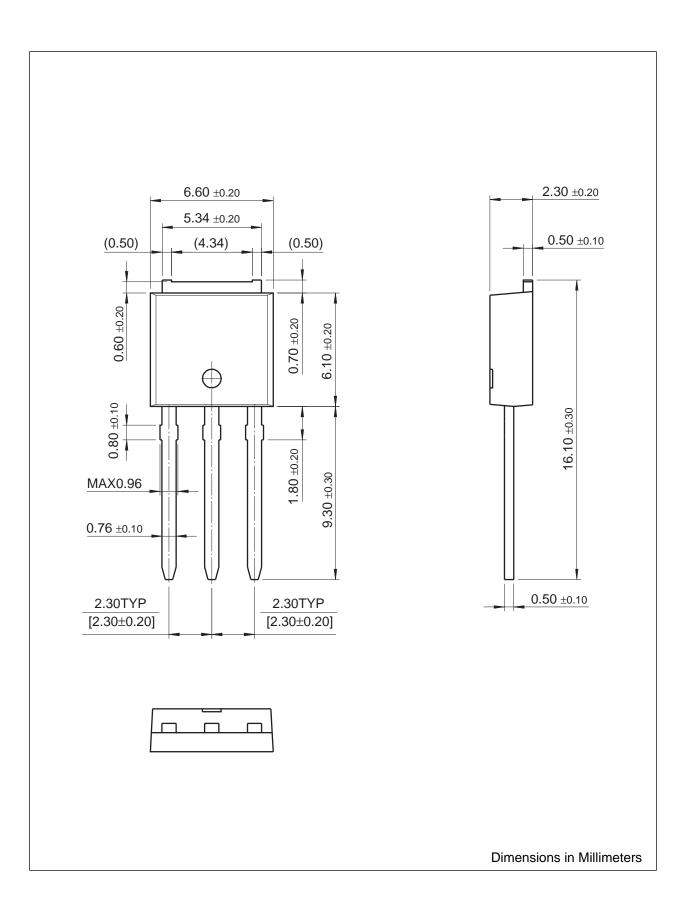
Typical Characteristics T_J = 25 °C unless otherwise noted

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AH&\$' \$ N-Channel Power[®] MOSFET







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